

General Features

• $V_{DS} = 60V, I_D = 0.3A$

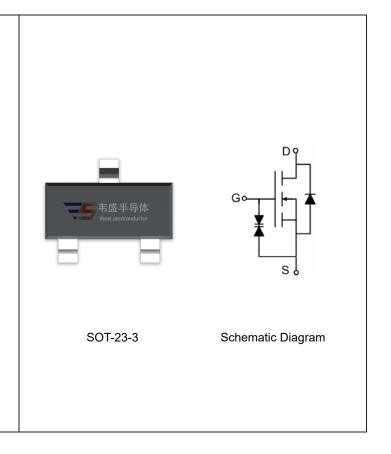
 $R_{DS(ON)} < 3\Omega$ @ V_{GS} =4.5V

 $R_{DS(ON)}$ < 2.2 Ω @ V_{GS} =10V

- High power and current handing capability
- Lead free product is acquired
- Surface mount package
- ESD Rating: HBM ≥1500V

Application

- Direct logic-level interface: TTL/CMOS
- Drivers: relays, solenoids, lamps, hammers, display, memories, transistors, etc.
- Battery operated systems
- Solid-state relays



Package Marking And Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM2N7002K-S2	VSM2N7002K	SOT-23-3	Ø180mm	8 mm	3000 units

Absolute Maximum Ratings (T_A=25 ℃unless otherwise noted)

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	60	V	
Gate-Source Voltage		Vgs	±20	V	
Continuous Drain Current (T」=150℃)	T _A =25℃		0.3	А	
Continuous Drain Current (1) = 150 C)	T _A =100°C	I _D	0.19		
Drain Current-Pulsed (Note 1)		I _{DM}	0.8		
Maximum Power Dissipation		P _D	0.35	W	
Operating Junction and Storage Temperature Range		T_{J}, T_{STG}	-55 To 150	$^{\circ}$	

Thermal Characteristic

Thermal Resistance,Junction-to-Ambient (Note 2)	R _{θJA}	350	°C/W
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Electrical Characteristics (T_A =25 $^{\circ}$ C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	60	68	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =60V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V_{GS} =±10V, V_{DS} =0V	-	-	±1	uA
Gate-body Leakage Guirent	IGSS	V_{GS} =±20 V , V_{DS} =0 V	-		±10	uA
On Characteristics (Note 3)				•		
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS},I_{D}=250\mu A$	0.7	1.3	1.9	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =4.5V, I _D =0.2A	-	1.95	3	Ω
Diani-Source On-State Resistance		V _{GS} =10V, I _D =0.3A	-	1.8	2.2	Ω
Forward Transconductance	g FS	V _{DS} =10V,I _D =0.2A	0.1	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C_{lss}	V _{DS} =25V,V _{GS} =0V,	10	21	50	PF
Output Capacitance	C_{oss}	V _{DS} -23V, V _{GS} -0V, F=1.0MHz	-	11	25	PF
Reverse Transfer Capacitance	C_{rss}	F-1.0WHZ	-	4.2	5	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	$t_{d(on)}$		-	10	-	nS
Turn-on Rise Time	t _r	V_{DD} =30 V , I_D =0.2 A	-	50	-	nS
Turn-Off Delay Time	$t_{d(off)}$	V_{GS} =10 V , R_{GEN} =10 Ω	-	17	-	nS
Turn-Off Fall Time	t _f		-	10	-	nS
Total Gate Charge	Q_g	V_{DS} =10V, I_{D} =0.3A, V_{GS} =4.5V	-	1.7	3	nC
Drain-Source Diode Characteristics	,			•		•
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =0.2A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	-	0.3	Α

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- **3.** Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production



Typical Electrical And Thermal Characteristics

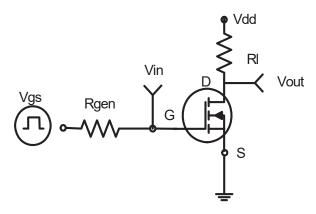


Figure 1:Switching Test Circuit

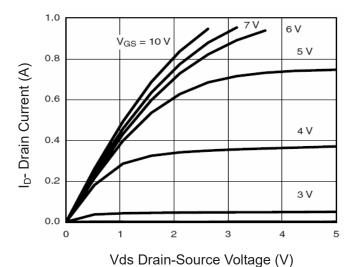


Figure 3 Output Characteristics

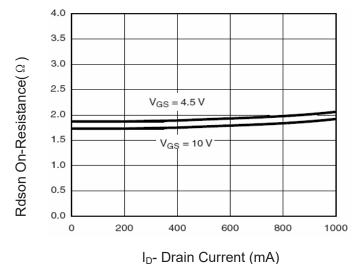


Figure 5 Drain-Source On-Resistance

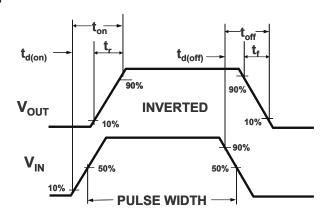


Figure 2:Switching Waveforms

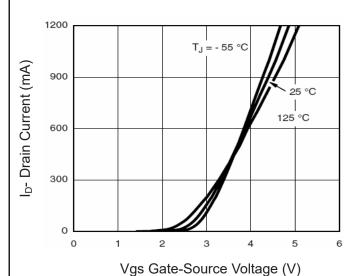


Figure 4 Transfer Characteristics

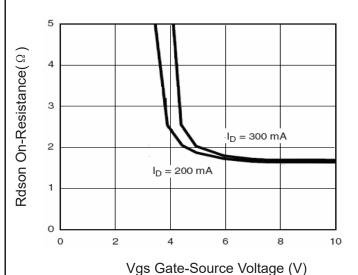
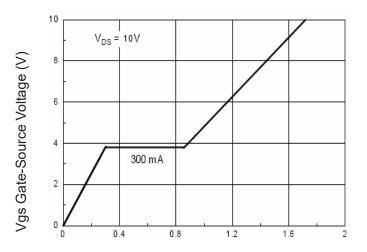


Figure 6 Rdson vs Vgs





Qg Gate Charge (nC) Figure 7 Gate Charge

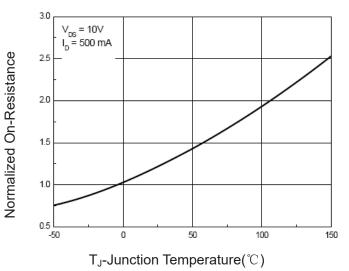


Figure 9 Drain-Source On-Resistance

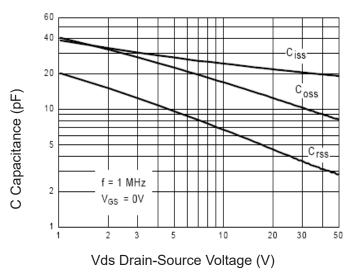
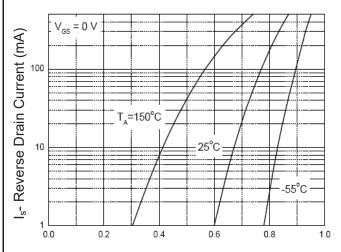
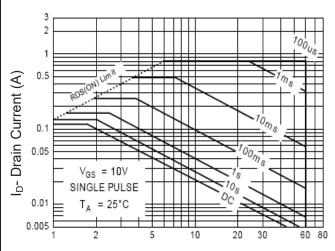


Figure 11 Capacitance vs Vds



Vsd Source-Drain Voltage (V)





Vds Drain-Source Voltage (V)

Figure 10 Safe Operation Area



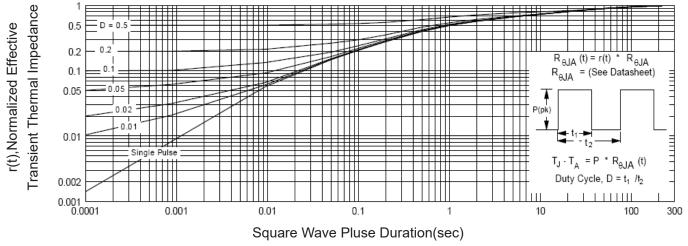


Figure 12 Normalized Maximum Transient Thermal Impedance